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What is claimed is:

A magnetic thin film head comprising:

a write head element; and

a read head element;

wherein a ferromagnetic film having a soft magnetic characteristic and a magnetic shield function is formed of NiFe permalloy material by electroplating in the vicinity of a sensor film arranged as said read head element,

wherein Ni in composition of a formed layer is 80.8 wt % to 82.0 wt %.

- 2. A magnetic thin film head according to claim 1, in which said Ni is composed of an initially formed layer having a thickness of 1.0 μ m is 80.8 to 82.0 wt%, and of an upper layer on said initially formed layer 1.0 μ m thick is 81.0 to 81.2 wt%.
- 20 3 A magnetic thin film head comprising: a write head element; and a read head element;

wherein a ferromagnetic film having a soft magnetic characteristic and a magnetic shield function is formed of NiFe permalloy material by electroplating in the vicinity of a sensor film arranged as said read head element.

wherein a magnetostriction constant λ

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representing a magnetic characteristic of said ferromagnetic film is -2.0 to -7.0 x 10^{-7} in an initially formed layer having a thickness of 1.0 μ m, and

wherein said magnetostriction constant λ is -3.0 to -4.0 x 10^{-7} in an upper layer on said initially formed layer 1.0 μ m thick.

4 A magnetic thin film head comprising:

a write head element; and

a read head element;

wherein a ferromagnetic film having a soft magnetic characteristic and a magnetic shield function is formed of NiFe permalloy material by electroplating in the vicinity of a sensor film arranged as said read head element.

wherein a film thickness exceeding 1.0 μ m in said ferromagnetic film formed of NiFe permalloy material has an Ni content accuracy of ± 0.1 wt%, and

wherein a film thickness of 1.0 μ m or less in said ferromagnetic film formed of NiFe permalloy material has an Ni content accuracy of ± 0.3 wt%.

- 5. A method of fabricating a magnetic thin film comprising the step of:
 - (a) forming a write head element;
 - (b) forming a read head element;
 wherein a ferromagnetic film having a soft

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magnetic characteristic and a magnetic shield function is formed of NiFe permalloy material by electroplating in the vicinity of a sensor film arranged as said read head element.

wherein Ni in composition of an initially formed layer having a thickness of 1.0 μ m is 80.8 to 82.0 wt%, and

wherein Ni in composition of an upper layer on said initially formed layer 1.0 μ m thick is 81.0 to 81.2 wt%,

(c) timewise regulating a current density of permalloy electroplating under control of a personal computer;

wherein a plurality of time periods and a plurality of current values are preset for film formation.

- 6. A method of fabricating a magnetic thin film comprising the step of:
 - (a) forming a write head element; and
 - (b) forming a read head element;

wherein a ferromagnetic film having a soft magnetic characteristic and a magnetic shield function is formed of NiFe permalloy material by electroplating in the vicinity of a sensor film arranged as said read head element.

wherein a magnetostriction constant $\boldsymbol{\lambda}$ representing a magnetic characteristic of said

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ferromagnetic film is -2.0 to -7.0 x 10^{-7} in an initially formed layer having a thickness of 1.0 μ m, and

wherein said magnetostriction constant λ is -3.0 to -4.0 x 10⁻⁷ in an upper layer on said initially formed layer 1.0 μ m thick,

(c) timewise regulating a current density of permalloy electroplating under control of a personal computer;

wherein a plurality of time periods and a plurality of current values are preset for film formation.

- 7. A method of fabricating a magnetic thin film comprising the step of:
 - (a) forming a write head element; and
 - (b) forming a read head element;

wherein a ferromagnetic film having a soft magnetic characteristic and a magnetic shield function is formed of NiFe permalloy material by electroplating in the vicinity of a sensor film arranged as said read head element.

wherein a film thickness exceeding 1.0 μ m in said ferromagnetic film formed of NiFe permalloy material has an Ni content accuracy of ± 0.1 wt%, and

wherein a film thickness of 1.0 μ m or less in said ferromagnetic film formed of NiFe permalloy material has an Ni content accuracy of ± 0.3 wt%,

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(c) timewise regulating a current density of permalloy electroplating under control of a personal computer;

wherein a plurality of time periods and a plurality of current values are preset for film formation.

- 8 A magnetic disk apparatus having a magnetic thin film head comprising:
 - a write head element; and
 - a read head element;

wherein a ferromagnetic film having a soft magnetic characteristic and a magnetic shield function is formed of NiFe permalloy material by electroplating in the vicinity of a sensor film arranged as said read head element.

wherein Ni in composition of an initially formed layer having a thickness of 1.0 μ m is 80.8 to 82.0 wt%, and

wherein Ni in composition of an upper layer on said initially formed layer 1.0 μ m thick is 81.0 to 81.2 wt%.

- 9 A magnetic disk apparatus having a 25 magnetic thin film head comprising:
 - a write head element: and
 - a read head element;

wherein a ferromagnetic film having a soft

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magnetic characteristic and a magnetic shield function is formed of NiFe permalloy material by electroplating in the vicinity of a sensor film arranged as said read head element

wherein a magnetostriction constant λ representing a magnetic characteristic of said ferromagnetic film is -2.0 to -7.0 x 10^{-7} in an initially formed layer having a thickness of 1.0 μ m, and

wherein said magnetostriction constant λ is -3.0 to -4.0 x 10^{-7} in an upper layer on said initially formed layer 1.0 μ m thick.

10 A magnetic disk apparatus having a magnetic thin film head comprising:

A magnetic thin film head comprising:

- a write head element: and
- a read head element;

wherein a ferromagnetic film having a soft magnetic characteristic and a magnetic shield function is formed of NiFe permalloy material by electroplating in the vicinity of a sensor film arranged as said read head element,

wherein a film thickness exceeding 1.0 μ m in said ferromagnetic film formed of NiFe permalloy material has an Ni content accuracy of ± 0.1 wt%, and

wherein a film thickness of 1.0 μ m or less in said ferromagnetic film formed of NiFe permalloy

material has an Ni content accuracy of ± 0.3 wt%.